#### 

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,784,463 A	07-1998	Chen et al.	713/171
*	В	US-6,061,796 A	05-2000	Chen et al.	726/15
*	С	US-6,151,675 A	11-2000	Smith, Jeffrey C.	713/153
*	D	US-6,158,011 A	12-2000	Chen et al.	726/15
*	E	US-2002/0010866 A1	01-2002	McCullough et al.	713/201
*	F	US-6,349,336 B1	02-2002	Sit et al.	709/227
*	G	US-2002/0103998 A1	08-2002	DeBruine, Timothy S.	713/153
*	Н	US-2002/0138744 A1	09-2002	Schleicher et al.	713/187
*	1	US-2002/0138576 A1	09-2002	Schleicher et al.	709/205
*	J	US-2002/0138440 A1	09-2002	Vaidyanathan et al.	705/54
*	К	US-2002/0138291 A1	09-2002	Vaidyanathan et al.	705/1
*	L	US-2002/0138362 A1	09-2002	Kitze et al.	705/26
*	М	US-2002/0162026 A1	10-2002	Neuman et al.	713/201

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•				
	0					
	Р					
	Q					
	R					
	s					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
,	٧	
	×	·
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/733,219 Applicant(s)/Patent Under Reexamination MARCJAN, CEZARY Examiner Art Unit Page 2 of 3

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0143944 A1	10-2002	Traversat et al.	709/225
*	В	US-2003/0009587 A1	01-2003	Harrow et al.	709/238
*	С	US-2003/0009518 A1	01-2003	Harrow et al.	709/203
*	D	US-2003/0009586 A1	01-2003	Harrow et al.	709/238
*	Ε	US-2003/0061287 A1	03-2003	Yu et al.	709/205
*	F	US-2003/0046587 A1	03-2003	Bheemarasetti et al.	713/201
*	G	US-2003/0131258 A1	07-2003	Kadri, Seemab Aslam	713/201
*	Н	US-2003/0179230 A1	09-2003	Seidman, Gerry	345/750
*	1	US-2003/0221009 A1	11-2003	Standridge et al.	709/227
*	J	US-6,754,831 B2	06-2004	Brownell, David	726/15
*	К	US-7,043,644 B2	05-2006	DeBruine, Timothy S.	713/153
*	L	US-7,047,406 B2	05-2006	Schleicher et al.	713/168
*	М	US-7,139,798 B2	11-2006	Zircher et al.	709/204

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0	·				
	Р					
	Q			,		
	R					
	s					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	5					
	v					
	w					
	×					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

### Application/Control No. Applicant(s)/Patent Under Reexamination 10/733,219 MARCJAN, CEZARY **Notice of References Cited** Examiner Art Unit Page 3 of 3 David G. Cervetti 2136 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code Name MM-YYYY US-7,150,040 B2 12-2006 Brownell, David 726/11 Α US-7,251,824 B2 07-2007 Edwards et al. 726/4 В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.